## Application/Control No. Applicant(s)/Patent Under Reexamination 10/813,352 CHENG ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2815 Matthew Landau **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY \* US-2005/0190590 09-2005 365/149 Chen et al. Α US-В US-C US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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